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Part 3: Abstract Test Suite (ATS) and Protocol Implementation eXtra Information for Testing (PIXIT)

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Foreword

This Technical Specification (TS) has been produced by ETSI Technical Committee Integrated broadband cable telecommunication networks (CABLE).

The present document is part 3 of a multi-part deliverable covering the conformance test specification for DS-Lite technology.

- Part 1: "Protocol Implementation Conformance Statement (PICS) proforma";
- Part 2: "Test Suite Structure and Test Purposes (TSS&TP)";
- Part 3: "Abstract Test Suite (ATS) and Protocol Implementation eXtra Information for Testing (PIXIT)".

The development of the present document follows the guidance provided in the ETSI EG 202 798 [i.1]. Therefore this ATS documentation is also based on the guidance provided in ETSI EG 202 798 [i.1].

Modal verbs terminology

In the present document "shall", "shall not", "should", "should not", "may", "may not", "need", "need not", "will", "will not", "can" and "cannot" are to be interpreted as described in clause 3.2 of the ETSI Drafting Rules (Verbal forms for the expression of provisions).

"must" and "must not" are NOT allowed in ETSI deliverables except when used in direct citation.

1 Scope

The present document contains the Abstract Test Suite (ATS) for DS-Lite technology as defined in RFC 6333 [1] and addressing specific cable industry requirements as defined in ETSI TS 101 569-1 [11] in compliance with the relevant requirements and in accordance with the relevant guidance given in ISO/IEC 9646-7 [5].

The objective of the present document is to provide a basis for conformance tests for DS-Lite technology equipment giving a high probability of inter-operability between different manufacturer's equipment.

The ISO standard for the methodology of conformance testing (ISO/IEC 9646-1 [2] and ISO/IEC 9646-2 [3]) as well as the ETSI rules for conformance testing (ETSI ETS 300 406 [6]) are used as a basis for the test methodology.

2 References

References are either specific (identified by date of publication and/or edition number or version number) or non-specific. For specific references, only the cited version applies. For non-specific references, the latest version of the reference document (including any amendments) applies.

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NOTE: While any hyperlinks included in this clause were valid at the time of publication, ETSI cannot guarantee their long term validity.

2.1 Normative references

The following referenced documents are necessary for the application of the present document.

[1]	IETF RFC 6333: "Dual-Stack Lite Broadband Deployments Following IPv4 Exhaustion".
[2]	ISO/IEC 9646-1 (1994): "Information technology Open Systems Interconnection Conformance testing methodology and framework Part 1: General concepts".
[3]	ISO/IEC 9646-2 (1994): "Information technology Open Systems Interconnection Conformance testing methodology and framework Part 2: Abstract Test Suite specification".
[4]	ISO/IEC 9646-6 (1994): "Information technology Open Systems Interconnection Conformance testing methodology and framework Part 6: Protocol profile test specification".
[5]	ISO/IEC 9646-7 (1995): "Information technology Open Systems Interconnection Conformance testing methodology and framework Part 7: Implementation Conformance Statements".
[6]	ETSI ETS 300 406 (1995): "Methods for testing and Specification (MTS); Protocol and profile conformance testing specifications; Standardization methodology".
[7]	ETSI ES 201 873-1: "Methods for Testing and Specification (MTS); The Testing and Test Control Notation version 3; Part 1: TTCN-3 Core Language".
[8]	Void.
[9]	Void.
[10]	ETSI TS 103 241-2: "Integrated broadband cable telecommunication networks (CABLE); Testing; Conformance test specifications for DS-Lite technology; Part 2: Test Suite Structure and Test Purposes (TSS&TP)".
[11]	ETSI TS 101 569-1: "Integrated Broadband Cable Telecommunication Networks (CABLE); Cable Network Transition to IPv6; Part 1: IPv6 Transition Requirements".

2.2 Informative references

The following referenced documents are not necessary for the application of the present document but they assist the user with regard to a particular subject area.

[i.1] ETSI EG 202 798: "Intelligent Transport Systems (ITS); Testing; Framework for conformance and interoperability testing".

3 Definitions and abbreviations

3.1 Definitions

For the purposes of the present document, the terms and definitions given in ETSI TS 101 569-1 [11], ISO/IEC 9646-1 [2] and ISO/IEC 9646-7 [5] apply.

3.2 Abbreviations

For the purposes of the present document, the following abbreviations apply.

3GPP Third Generation Partnership Project
AFTR Address Family Transition Router
ASP Abstract Services Primitives
ATM Abstract Test Method

ATS Abstract Test Method
ATS Abstract Test Suite

B4 (DS-Lite) Basic Bridging BroadBand element

CPE Customer Premises Equipment

DHCP Dynamic Host Configuration Protocol

DNS Domain Name System
FTP File Transfer Protocol
GRT Global Routing Table
HTML HyperText Markup Language
HTTP HyperText Transfer Protocol

IP Internet Protocol IPv4 IP version 4 IPv6 IP version 6

IUT Implementation Under Test
MSS Maximum Segment Size
MTC Main Test Component

MTS Methods for Testing and Specification

OSI Open System Interconnection

PA Platform Adaptor PDU Protocol Data Unit

PICS Protocol Implementation Conformance Statement
PIXIT Protocol Implementation Extra Information for Testing

PTC Parallel Test Component
SUT System Under Test
TA Test Adaptor
TC Test Case

TCP Transmission Control Protocol

TP Test Purpose
TSS Test Suite Structure

TTCN Testing and Test Control Notation VRF Virtual Routing and Forwarding

4 Abstract test method

This clause describes the ATM used to test the DS-Lite technology.

4.1 Abstract protocol tester

An abstract protocol tester presented in figure 1 is a process providing the test behaviour for testing an IUT. Thus it will emulate an entity which is capable of proving the IUT functionalities. This type of test architecture provides a situation of communication which is equivalent to real operation between real devices. The test system will simulate valid and invalid behaviours, and will analyse the reaction of the IUT. Then the test verdict, e.g. pass or fail, will depend on the result of this analysis. Thus this type of test architecture enables to focus the test objective on the IUT behaviour only.

In order to access an IUT, the corresponding abstract protocol tester needs to use lower layers to establish a proper connection to the system under test (SUT) over a physical link (Lower layers link).

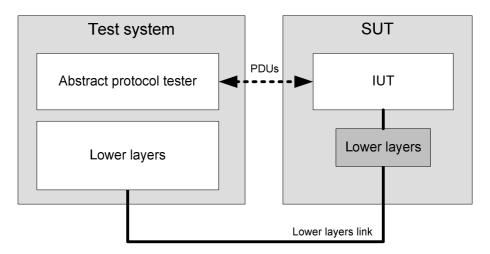


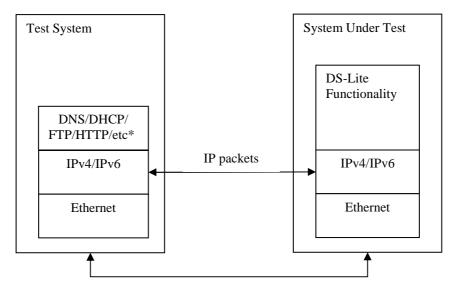
Figure 1: Generic abstract protocol tester

The "Protocol Data Units" (PDUs) are the messages exchanged between the IUT and the abstract protocol tester which permits to trigger the IUT and to analyse its reactionThe result of the analysis allows to assign the test verdict.

Further control actions on the IUT may be necessary from inside the SUT, for instance to simulate a primitive from the upper layer or the management/security entity. Further details on such control actions are provided by means of an upper tester presented in clause 4.3.

The above "Abstract Test Method" (ATM) is well defined in ISO/IEC 9646-1 [2] and supports a wide range of approaches for testing including the TTCN-3 abstract test language [7].

The abstract protocol tester used for DS-Lite test suite is described in figure 2. The test system will send and receive IP packets, by using other upper layer protocols such as DHCP, DNS and FTP, in order to analyse DS-Lite functionality.



Lower Layers Link

NOTE: * Those protocols are used to prove certain DS-Lite functionalities.

Figure 2: Abstract Protocol Tester - DS-Lite

4.2 Test configurations

The test suite for DS-Lite uses two test configurations in order to cover the different test scenarios. Distinction between the two configurations is given by the two main components in DS-Lite, which are B4 and AFTR.

4.2.1 CF01: B4 as IUT

In this configuration, the B4 is the IUT and the test system simulates an AFTR in one side and a IPv4 host in the other side.

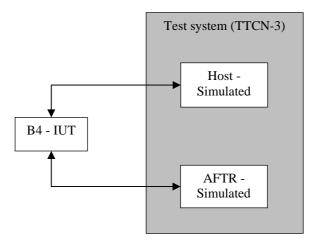


Figure 3: CF01, B4 equipment is the IUT

4.2.2 CF02: AFTR as IUT

In this configuration, the AFTR is the IUT and the test system simulates a B4 equipment in one side and an IPv4 host in the other side.

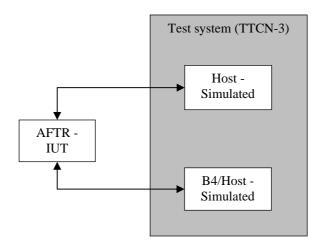


Figure 4: CF02, AFTR equipment is the IUT

4.3 TTCN-3 Test architecture

In general, a conformance test system architecture based on TTCN-3 is as figure 5 shows.

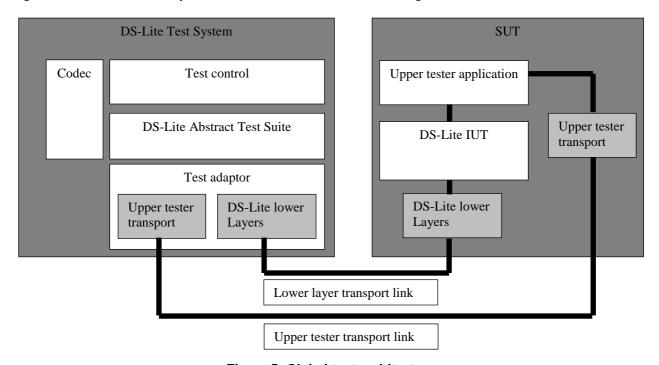


Figure 5: Global test architecture

The "System Under Test" (SUT) contains:

- The "Implementation Under Test" (IUT), i.e. the object of the test.
- The "Upper tester application" enables to trigger or capture some actions (i.e. higher layer service primitives) on the IUT.
- The "DS-Lite lower layers" enable to establish a proper connection to the system under test (SUT) over a physical link (Lower layer transport link).

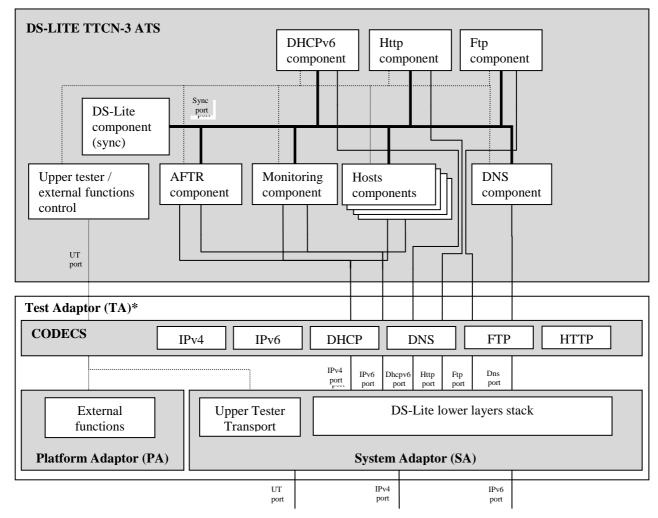
• The "Upper tester transport" is a functionality, which enables the test system to communicate with the upper tester application. Then the upper tester can be controlled by a TTCN-3 test component as part of the test process.

The "DS-Lite test system" contains:

- The "TTCN-3 test components" are processes providing the test behaviour. The test behaviour may be provided as one single process or may require several independent processes.
- The "Codec" is a functional part of the test system to encode and decode messages between the TTCN-3 internal data representation and the format required by the related base standard.
- The "Test Control" enables the management of the TTCN-3 test execution (parameter input, logs, test selection, etc.).
- The "Test adaptor" (TA) realizes the interface between the TTCN-3 ports using TTCN-3 messages, and the physical interfaces provided by the IUT.

Based on the above test architecture, figure 6 shows a detailed test architecture used for the DS-Lite. The DS-Lite ATS requires using several Parallel Test Components (PTC) dealing with specific communication protocols and a Main Test Component (MTC) dealing with PTCs' synchronization. The different test components communicate with the DS-Lite SUT over several ports (described in clause 4.4) which are used to exchange protocol messages between the test components and the DS-Lite IUT.

The Upper tester entity enables triggering some functionalities by simulating actions or primitives from above applications.



NOTE: *Test Adaptor (TA) is out of scope.

Figure 6: DS-Lite TTCN-3 test architecture

The following protocol test components are available. Each of these components can be mapped to either a "Main Test Component" (MTC), when only one component shall be executed, or to a "Parallel Test Component" (PTC), if several components shall be used.

- **AFTR:** This component simulates an AFTR entity and its functionality.
- **HOST:** These components simulate one or more hosts (one component per host).
- **MONITORING:** This component is used to monitor traffic from the IUT.
- **DNS:** This component simulates a DNS Client.
- **DHCP:** This component simulates a DHCPv6 Client.
- **FTP:** This component simulates a FTP client.
- **HTTP:** This component simulates a HTTP client.

The **Sync** component is mapped to the MTC and is used to trigger and synchronize the PTCs in order to orchestrate the test environment executed by the PTCs. In addition, it starts and terminates the test cases.

The **upper tester external functions control** represents the functions which the protocol test components may use to control the upper tester which is located in the SUT. These functions may use either external functions or dedicated messages and a dedicated port to realise synchronization. These functions can be executed in the protocol test components.

4.4 Ports and ASPs (Abstract Services Primitives)

4.4.1 TTCN-3 ports

The DS-Lite Test Suite implements the following ports:

- **Ipv6Port**, to send and receive IPv6 packets.
- **Ipv4Port**, to send and receive IPv4 packets.
- **DnsPort**, to send and receive DNS messages.
- **Dhcpv6Port**, to send and receive DHCPv6 messages.
- **FtpPort**, to trigger the following FTP actions: login, logout, and data sending (both IPv4 and IPv6). It can monitor incoming traffic.
- **HttpPort**, to trigger the following HTTP actions: data sending (both IPv4 and IPv6). It can monitor incoming traffic.
- **UtPort**, included in order to be able to stimulate the IUT and receive extra information from IUT upper layers (it is not used in the current implementation and is provided for future expansion).

4.4.2 Abstract Service Primitives

Abstract service primitives are commands or actions that need to be performed on the IUT in order to trigger certain behaviour or to obtain information about the IUT state.

The list of ASP used in the DS-Lite ATS is shown in table 1.

Table 1. DS-Lite Abstract Service Primitives

TTCN-3 text	Action/Command	Description
Are routing tables configured GRT upstream	Action	To check that routing tables are
ingress & VRF upstream egress?		properly configured
Is Gateway Prefix withdrawn?	Action	To check that the gateway prefix is
		withdrawn
Remove the route	Command	To remove the route from IUT routing
		tables
Remove the cache	Command	To remove the IUT cache

5 Implemented Test Purposes

Table 2 shows the test purposes from ETSI TS 103 241-2 [10] which have been implemented and included in the present document.

PICS Untestable TP Identifier TC Identifier Group Subgroup Implemented PICS ROLE IS B4 TP/DSLITE/B4/GWA/BV/001 TC_DSLITE_B4_GWA_BV_01 Yes Gateway TP/DSLITE/B4/GWA/BV/002 TC_DSLITE_B4_GWA_BV_02 PICS_ROLE_IS_B4 Yes Assignment TP/DSLITE/B4/GWA/BV/003 TC_DSLITE_B4_GWA_BV_03 PICS_ROLE_IS_B4 Yes TP/DSLITE/B4/BF/BV/001 TC_DSLITE_B4_BF_BV_01 PICS_ROLE_IS_B4 Basic Function Yes B4 TP/DSLITE/B4/FRAG/BV/001 TC DSLITE B4 FRAG BV 01 PICS ROLE IS B4 Yes Fragmentation TP/DSLITE/B4/FRAG/BV/002 TC_DSLITE_B4_FRAG_BV_02 PICS_ROLE_IS_B4 Yes Maximum PICS ROLE IS B4 TP/DSLITE/B4/MSS/BV/002 TC DSLITE B4 MSSC BV 01 Yes Segment Size TP/DSLITE/AFTR/BF/BV/001 TC_DSLITE_AFTR_BF_BV_01 PICS_ROLE_IS_AFTR Yes TC_DSLITE_AFTR_BF_BV_02 Basic Function PICS_ROLE_IS_AFTR TP/DSLITE/AFTR/BF/BV/002 Yes TC DSLITE AFTR BE TL 01 TP/DSLITE/AFTR/BF/TI/001 PICS ROLE IS AFTR Yes Application TP/DSLITE/AFTR/ALG/BV/001 TC_DSLITE_AFTR_ALG_BV_01 PICS_ROLE_IS_AFTR Yes Layer Gateway AFTR TP/DSLITE/AFTR/RT/BV/001 TC_DSLITE_AFTR_RT_BV_01 PICS_ROLE_IS_AFTR Yes Routing Tables TC_DSLITE_AFTR_RT_BV_02 TP/DSLITE/AFTR/RT/BV/002 PICS_ROLE_IS_AFTR Yes Yes TP/DSLITE/AFTR/AW/VB/01 TC_DSLITE_AFTR_AW_BV_01 Address PICS_ROLE_IS_AFTR Withdrawal TP/DSLITE/AFTR/AW/VB/02 TC_DSLITE_AFTR_AW_BV_02 PICS ROLE IS AFTR Yes TP/DSLITE/AFTR/FRAG/VB/01 TC DSLITE AFTR FRAG BV 01 Fragmentation PICS_ROLE_IS_AFTR Yes

Table 2: Implemented Test Purposes

6 ATS conventions

The ATS conventions are intended to give a better understanding of the ATS but they also describe the conventions made for the development of the ATS. These conventions shall be considered during any later maintenance or further development of the ATS.

6.1 Naming conventions

This test suite follows the naming convention guidelines provided in ISO/IEC 9646-6 [4] and ETSI EG 202 798 [i.1].

6.1.1 General guidelines

The naming convention is based on the following underlying principles:

- Identifiers should be prefixed with a short alphabetic string (specified in table 3) indicating the type of TTCN-3 element it represents.
- Suffixes should not be used except in those specific cases identified in table 3.
- Prefixes and suffixes should be separated from the body of the identifier with an underscore ("_").

EXAMPLE 1: c_sixteen, t_wait.

- Only module names, data type names and module parameters should begin with an upper-case letter. All other names (i.e. the part of the identifier following the prefix) should begin with a lower-case letter.
- The start of second and subsequent words in an identifier should be indicated by capitalizing the first character. Underscores should not be used for this purpose.

EXAMPLE 2: f_initialState.

Table 3 specifies the naming guidelines for each element of the TTCN-3 language indicating the recommended prefix, suffixes (if any) and capitalization.

Table 3: ETSI TTCN-3 generic naming conventions

Language element	Naming convention	Prefix	Example identifier
Module	Use upper-case initial letter	AtsDSLite_	AtsDSLite_Templates
Group within a module	Use lower-case initial letter	none	aftrSut
Data type	Use upper-case initial letter	none	SetupContents
Message template	Use lower-case initial letter	m_	m_ipv4Packet_dummy
Message template with wildcard or	Use lower-case initial letters	mw_	mw_dns_dummy
matching expression			
Modifying message template	Use lower-case initial letter	md_	md_setupInit
Modifying message template with	Use lower-case initial letters	mdw_	mdw_dnsData_query
wildcard or matching expression			
Signature template	Use lower-case initial letter	S_	s_callSignature
Port instance	Use lower-case initial letter	none	dnsPort
Test component instance	Use lower-case initial letter	none	HostComponent
Constant	Use lower-case initial letter	C_	c_portExt
Constant (defined within component type)	Use lower-case initial letter	CC_	cc_minDuration
External constant	Use lower-case initial letter	CX_	cx_macld
Function	Use lower-case initial letter	f_	f_cf01Up()
External function	Use lower-case initial letter	fx_	fx_calculateLength()
Altstep (incl. Default)	Use lower-case initial letter	a_	a_default()
Test case	Use ETSI numbering	TC_	TC_DSLITE_B4_GWA_BV_001
Variable (local)	Use lower-case initial letter	V_	v_dhcpMessage
Variable (defined within a component	Use lower-case initial letters	vc_	vc_aftrComponent
type)			
Timer (local)	Use lower-case initial letter	t_	t_wait
Timer (defined within a component)	Use lower-case initial letters	tc_	tc_ac
Module parameters for PICS	Use all upper case letters	PICS_	PICS_ROLE_RH
Module parameters for other parameters	Use all upper case letters	PX_	PX_LINK_ID
Formal Parameters	Use lower-case initial letter	p_	p_commRef
Enumerated Values	Use lower-case initial letter	e_	e_success

6.1.2 DS-LITE specific TTCN-3 naming conventions

In addition to such general naming conventions, table 4 shows specific naming conventions that apply to the DS-Lite technology TTCN-3 test suite.

Table 4: DS-LITE specific TTCN-3 naming conventions

Language element	Naming convention	Prefix	Example identifier
Ds-Lite Module	Use upper-case initial letter	AtsDsLite_	AtsDsLite_
Module containing types and values	Use upper-case initial letter	AtsDsLite_TypesAndValues	AtsDsLite_TypesAndValues
Module containing Templates	Use upper-case initial letter	AtsDsLite_Templates	AtsDsLite_Templates
Module containing test cases	Use upper-case initial letter	AtsDsLite_TestCases	AtsDsLite_TestCases
Module containing functions	Use upper-case initial letter	AtsDsLite_Functions	AtsDsLite_Functions
Module containing external functions	Use upper-case initial letter	AtsDsLite_ExternalFunctions	AtsDsLite_ExternalFunctions
Module containing components, ports and message definitions	Use upper-case initial letter	AtsDsLite_Interfaces	AtsDsLite_Interfaces
Module containing main component definitions	Use upper-case initial letter	AtsDsLite_TestSystem	AtsDsLite_TestSystem
Module containing the control part	Use upper-case initial letter	AtsDsLite_TestControl	AtsDsLite_TestControl

6.1.3 Usage of Log statements

All TTCN-3 log statements use the following format:

- Three asterisks followed by a blank character.
- The TTCN-3 test case or function identifier in which the log statement is defined followed by a colon and a blank character.
- One of the log categories: INFO, WARNING, ERROR, PASS, FAIL, INCONC, TIMEOUT followed by a colon and a blank character.
- Free text.
- A blank character followed by three asterisks.

EXAMPLE 1: log("***TC_DSLITE_B4_DHCP_BV_01: INFO: Preamble: IUT was setup properly ***");

Furthermore, the following rules are applied for the Fsap ATS:

- Log statements are used in the body of the functions, so that invocation of functions are visible in the test logs.
- All TTCN-3 setverdict statements are combined (as defined in TTCN-3) with a log statement following the same above rules (see example 2).

EXAMPLE 2: setverdict(pass, "*** TC_DSLITE_B4_DHCP_BV_01: PASS: DHCPv6 messages received ***");

6.1.4 Test Case (TC) identifier

The identifier of the TC is built according to table 5 as recommended in ETSI ETS 300 406 [6].

Table 5: TC naming convention for DS-Lite

TC_ <root>_<gr>_<x>_<nn></nn></x></gr></root>			
<root> = root</root>	DSLITE	Dual-Stack Lite	
<gr> = group</gr>	B4	B4 as IUT	
	AFTR AFTR as IUT		
<sgr> = sub-group</sgr>	GWA	Gateway Assignment	
	BF	Basic Function	
	FRAG	Fragmentation	
	ALG	Application Layer Gateway	
	MSSC	Maximum Segment Size Clamping	
	RT	Routing Tables	
	AW	Address Withdrawal	
<x> = type of testing</x>	BV	Valid Behaviour tests	
	TI	Timer Tests	
<nn> = sequential number</nn>		01 to 99	
NOTE: A sub-group may not apply for all groups.			

EXAMPLE: TP identifier: TP/DSLITE/B4/GWA/BV/01 or TP/DSLITE/B4/BF/BV/01

TC identifier: TC_DSLITE_B4_GWA_BV_01 or TC_DSLITE_B4_BF_BV_01.

6.2 On line documentation

Using the T3D tool enables providing on-line documentation browser in HTML, by tagging TTCN-3 comments. These tags are defined in table 6.

Table 6: TTCN-3 comment tags

Tag	Description	
@author	Specifies the names of the authors or an authoring organization which either has created or is maintaining a particular piece of TTCN-3 code.	
@desc	Describes the purpose of a particular piece of TTCN-3 code. The description should be concise yet informative and describe the function and use of the construct.	
@remark	Adds extra information, such as the highlighting of a particular feature or aspect not covered in the description.	
@see	Refers to other TTCN-3 definitions in the same or another module.	
@return	Provides additional information on the value returned by a given function.	
@param	Documents the parameters of parameterized TTCN-3 definitions.	
@version	States the version of a particular piece of TTCN-3 code.	

The HTML files result from the compilation of the TTCN-3 modules with the T3Doc tool. These HTML files are ready for browsing, and contains links enabling to navigate through the ATS.

EXAMPLE:

Annex A (normative): Partial PIXIT proforma for DS-LITE

Notwithstanding the provisions of the copyright clause related to the text of the present document, ETSI grants that users of the present document may freely reproduce the Partial PIXIT proforma in this annex so that it can be used for its intended purposes and may further publish the completed Partial PIXIT.

A.1 Identification summary

Table A.1

PIXIT Number:	
Test Laboratory Name:	
Date of Issue:	
Issued to:	

A.2 ATS summary

Table A.2: Summary

Protocol Specification:	
Protocol to be tested:	
ATS Specification:	
Abstract Test Method:	

A.3 Test laboratory

Table A.3: Test laboratory

Test Laboratory Identification:	
Test Laboratory Manager:	
Means of Testing:	
SAP Address:	

A.4 Client identification

Table A.4: Client identification

Client Identification:	
Client Test manager:	
Test Facilities required:	

A.5 SUT

Table A.5: SUT identification

Name:	
Version:	
SCS Number:	
Machine configuration:	
Operating System Identification:	
IUT Identification:	
PICS Reference for IUT:	
Limitations of the SUT:	
Environmental Conditions:	

A.6 Protocol layer information

A.6.1 Protocol identification

Table A.6: Protocol identification

Name:	
Version:	
PICS References:	

A.6.2 IUT information

Table A.7: DS-Lite Pixits

Identifier		Description
PX_AFTR_B4_IPv4ADDRESS	Comment	Indicates the IPv4 address of the
		B4 equipment
	Туре	Ipv4Address
	Def. value	0
PX_AFTR_B4_ADDRESS	Comment	ndicates the IPv6 address of the
		B4 equipment
	Туре	Ipv6Address
	Def. value	0
PX_AFTR_B4_ADDRESS_OTHER	Comment	
	Туре	Ipv6Address
	Def. value	0
PX_AFTR_GW_ADDRESS	Comment	Indicates the IPv6 address of the
		AFTR equipment
	Туре	Ipv6Address
	Def. value	Ö
PX_WEB_SERVER_IPv4	Comment	Indicates the IPv4 WEB server
		address
	Туре	Ipv4Address
	Def. value	0
PX_HOST_V4_LIST_B4	Comment	Defines a list of IPv4 host services
	Туре	
	Def. value	
PX_HOST_V4_LIST_AFTR	Comment	Defines a list of IPv4 host services
	Type	
	Def. value	
PX_HOST_V4_LIST_FTP	Comment	Defines a list of IPv4 host services
	Туре	
	Def. value	
PX DS MSS SIZE	Comment	The MSS value
	Туре	UInt
	Def. value	1500
PX_DS_MTU	Comment	The DS-Tunnel-MTU value
	Туре	UInt
	Def. value	1500
PX_FTP_SERVER_IPv4	Comment	he IPv4 address of an FTP server
	Type	Ipv4Address
	Def. value	0

Annex B (normative): PCTR Proforma for DS-Lite

Notwithstanding the provisions of the copyright clause related to the text of the present document, ETSI grants that users of the present document may freely reproduce the PCTR proforma in this annex so that it can be used for its intended purposes and may further publish the completed PCTR.

The PCTR proforma is based on ISO/IEC 9646-6 [4]. Any needed additional information can be found in this International standard document.

B.1 Identification summary

B.1.1 Protocol conformance test report

Table B.1

PCTR Number:	
PCTR Date:	
Corresponding SCTR Number:	
Corresponding SCTR Date:	
Test Laboratory Identification:	
Test Laboratory Manager:	
Signature:	

B.1.2 IUT identification

Table B.2

Name:	
Version:	
Protocol specification:	
PICS:	
Previous PCTR if any:	

B.1.3 Testing environment

Table B.3

PIXIT Number:	
ATS Specification:	
Abstract Test Method:	
Means of Testing identification:	
Date of testing:	
Conformance Log reference(s):	
Retention Date for Log reference(s):	

B.1.4 Limits and reservation

Additional information relevant to the technical contents of further use of the test report, or the rights and obligations of the test laboratory and the client, may be given here. Such information may include restriction on the publication of the report.
B.1.5 Comments Additional comments may be given by either the client or the test laboratory on any of the contents of the PCTR, for example, to note disagreement between the two parties.

B.2 IUT Conformance status

This IUT has or has not been shown by conformance assessment to be non-conforming to the specified protocol specification.

Strike the appropriate words in this sentence. If the PICS for this IUT is consistent with the static conformance requirements (as specified in clause B.3 in the present document) and there are no "FAIL" verdicts to be recorded (in clause B.6 in the present document) strike the words "has or", otherwise strike the words "or has not".

B.3 Static conformance summary

The PICS for this IUT is or is not consistent with the static conformance requirements in the specified protocol.

Strike the appropriate words in this sentence.

B.4 Dynamic conformance summary

The test campaign did or did not reveal errors in the IUT. Strike the appropriate words in this sentence. If there are no "FAIL" verdicts to be recorded (in clause B.6 of the present document) strike the words "did or" otherwise strike the words "or did not". Summary of the results of groups of test: Static conformance review report B.5 If clause B.3 indicates non-conformance, this clause itemizes the mismatches between the PICS and the static conformance requirements of the specified protocol specification.

B.6 Test campaign report

Table B.4: Test cases

ATS Reference	Selected?	Run?	Verdict	Observations (Reference to any observations made in clause B.7)
	Yes/No	Yes/No		
	Yes/No Yes/No	Yes/No Yes/No		
	Yes/No	Yes/No		
	Yes/No Yes/No	Yes/No Yes/No		
	Yes/No	Yes/No		
	Yes/No Yes/No	Yes/No Yes/No		
	Yes/No	Yes/No		

3.7 Observations
dditional information relevant to the technical content of the PCTR is given here.

Annex C (normative): TTCN-3 library modules

This ATS has been produced using the Testing and Test Control Notation (TTCN) according to ETSI ES 201 873-1 [7]. The ATS was developed on a separate TTCN software tool and therefore the TTCN tables are not completely referenced in the table of contents. The ATS itself contains a test suite overview part which provides additional information and references.

This test suite has been compiled error-free using three different commercial TTCN-3 compilers.

C.1 Electronic annex, zip file with TTCN-3 code

The TTCN-3 library modules, which form parts of the present doument, are contained in archive ts_10324103v010101p0.zip which accompanies the present document.

Annex D (informative): Bibliography

- ETSI ES 201 873-7: "Methods for Testing and Specification (MTS); The Testing and Test Control Notation version 3; Part 7: Using ASN.1 with TTCN-3".
- ETSI TS 103 241-1: "Integrated broadband cable telecommunication networks (CABLE) Testing; Conformance test specifications for DS-Lite technology; Part 1: Test requirements and Protocol Implementation Conformance Statement (PICS) proforma".

History

Document history		
V1.1.1	December 2014	Publication